

Generic Interface Boards for Teradyne Testers

Board Part #	Device Type	Device Org.	Device Pkg.	Device Pin Cnt.	Board Type	# of Sites	Socket
J937-1504-00	UNIV		SIMM	72	DIB	2	Yamaichi IC-176-2
J937-1507-00	UNIV		SOJ	CONT	DIB		Yamaichi IC100 & IC107 Series, 300/400/500/600 mil Widths
J937-1508-00	UNIV		TSOP	CONT	DIB		Enplas OTS-40(44)-0.8-01-000
J937-4504-00	UNIV		DIP	CONT	DIB		300/400/600 mil Widths
J997-1601-00	UNIV		SOJ	28	DIB	4	Yamaichi IC100 & IC107 Series
J997-1602-03	UNIV		SOJ	CONT	DIB		Yamaichi IC100 & IC107 Series, 300/350/400/450/500 mil Widths
J997-1603-00	UNIV		SIMM	72	DIB	1	Yamaichi IC-176-2
J997-1604-00	UNIV		SIMM	40 84	DIB	2	Yamaichi IC-176-2 Yamaichi IC-176-4
J997-1605-00	UNIV		TSOP	44	DIB	4	Enplas OTS-40(44)-0.8-01-000
J997-1606-00	UNIV		PLCC	84	DIB	1	Yamaichi IC51-0844-401-1
J997-1607-00	UNIV		BGA	119	DIB	1	Wells 6541191128010705
J997-1608-00	UNIV		PQFP	100	DIB	1	Enplas FPQ-100-0.65-16A
J997-1609-00	UNIV		TSOP II SOP	44	DIB	4	Enplas OTS-44-1.27-03 Enplas OTS-28-1.27-17
J997-1610-00	UNIV		TSOP II	CONT	DIB		Yamaichi IC235-0502-009 Yamaichi IC235-0542-018
J997-1805-00	UNIV			256	PROBE		
J997-IDS5K-00	UNIV				EIB		
J971-D301-00	UNIV		PGA		DIB		
J994-1701-00	UNIV				DIB		100 X 100 mil Grid
J994-1703-00	DRAM	4M X 4	SOJ	28	DIB	32	Yamaichi IC107-2804
J994-1704-00	UNIV		SOJ	CONT	DIB		Yamaichi IC100 & IC107 Series 350/400/450/500/600 mil W
J994-1705-00	UNIV				DIB		
J996-1611-00	UNIV		TSOP		DIB		300/400/500/600 mil Widths 1.27 / 0.8mm Pitch
A500-101-00	UNIV				DIB		100 X 100 mil Grid
A500-102-00	UNIV				PIB		
A580-201-00	UNIV				DIB		100 X 100 mil Grid
CAT-301-00	UNIV				DIB		100 X 100 mil Grid

DIB

Device Interface Board

PIB

Probe Interface Board

EIB

E-beam Interface Board

UNIV

Universal

CONT

Contiguous

PROBE

Probe Card

CAT

Catalyst



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